

MOSFET - Power, Single **N-Channel, TOLL**

40 V, 0.95 mΩ, 300 A

FDBL9403-F085T6

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- Small Footprint (TOLL) for Compact Design
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage	€		V _{GS}	+20/-16	V
Continuous Drain		T _C = 25°C	I _D	300	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		217	
Power Dissipation	State	T _C = 25°C	P_{D}	159.6	W
R _{θJC} (Note 1)		T _C = 100°C		79.8	
Continuous Drain		T _A = 25°C	I _D	50	Α
Current $R_{\theta JA}$ (Notes 1, 2, 3)	Steady State	T _A = 100°C		36	
Power Dissipation		T _A = 25°C	P_{D}	4.3	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		2.1	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	3565	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			IS	330	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 35 A, L = 1 mH)			E _{AS}	612.5	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

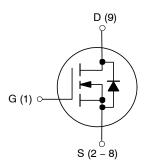
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.94	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	35	

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Current is limited by bondwire configuration.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

	V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
ı	40 V	$0.95~\text{m}\Omega$ @ $10~\text{V}$	300 A



N-CHANNEL MOSFET



H-PSOF8L CASE 100CU

ORDERING INFORMATION

Device	Package	Shipping [†]
FDBL9403-F085T6	H-PSOF8L (Pb-Free)	2000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Table 1. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				22		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	T _J = 25°C			1	μΑ
		-	T _J = 175°C		310		μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	+20/–16 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	2	2.8	4	V
Threshold Temperature Coefficient	V _{GS(th)} /T _J				-7.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _I	_D = 50 A		0.84	0.95	mΩ
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25	V, f = 100 KHz		6985		pF
Output Capacitance	C _{oss}				3720		pF
Reverse Transfer Capacitance	C _{rss}				68		pF
Gate Resistance	Rg	V _{GS} = 0.5 V, f = 1 MHz			1.1		Ω
Total Gate Charge	Q _{G(tot)}	V _{GS} = 10 V, V _{DS} = 20 V, I _D = 50 A			108		nC
Threshold Gate Charge	Q _{G(th)}	V _{GS} = 0 to	2 V		13		nC
Gate-to-Source Gate Charge	Q _{gs}	V _{DD} = 22 V, I _D = 50 A			28		nC
Gate-to-Drain "Miller" Charge	Q _{gd}				23		nC
Plateau Voltage	V _{GP}				4.4		V
SWITCHING CHARACTERISTICS (Note 5)						
Turn-On Delay Time	t _{d(on)}	$V_{GS} = 10 \text{ V}, V_{E}$ $I_{D} = 50 \text{ A}, R_{G}$	_{DD} = 20 V,		33		ns
Turn-On Rise Time	t _r	$I_D = 50 \text{ A}, R_{G_1}$	EN = 6 Ω		56		ns
Turn-Off Delay Time	t _{d(off)}				84		ns
Turn-Off Fall Time	t _f				39		ns
DRAIN-SOURCE DIODE CHARACTERIS	TICS			_	•	-	-
Source-to-Drain Diode Voltage	V_{SD}	I _{SD} = 50 A, V ₀	_{GS} = 0 V		0.79	1.2	V
Reverse Recovery Time	t _{rr}	V_{GS} = 0 V, dI_S/d_t = 100 A/ μ s, I_S = 50 A			84		ns
Charge Time	ta				54		ns
Discharge Time	t _b				30		ns
Reverse Recovery Charge	Q _{rr}				172		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS

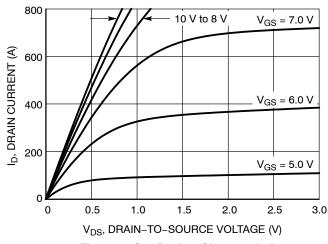


Figure 1. On-Region Characteristics

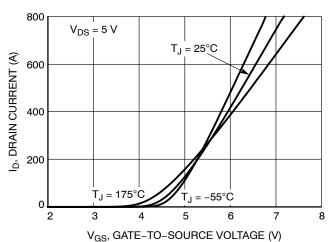


Figure 2. Transfer Characteristics

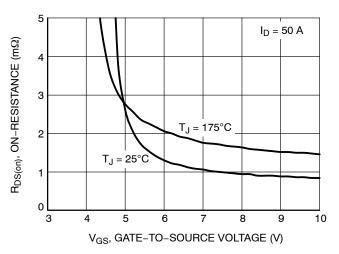


Figure 3. On-Resistance vs. Gate-to-Source Voltage

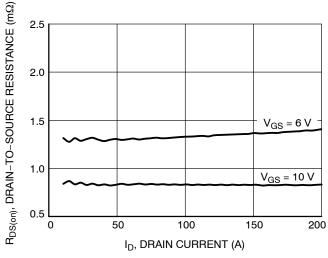


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

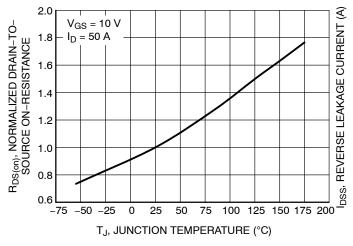


Figure 5. On–Resistance Variation with Temperature

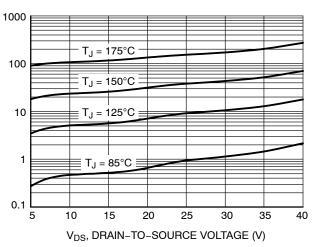


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

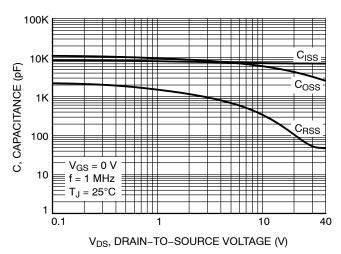


Figure 7. Capacitance Variation

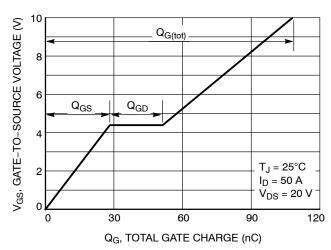


Figure 8. Gate-to-Source Voltage vs. Total Charge

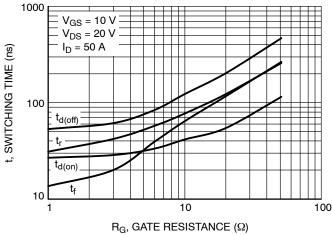


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

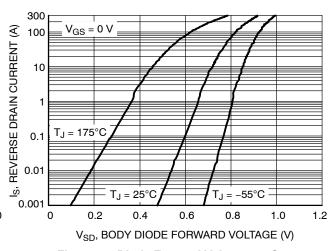


Figure 10. Diode Forward Voltage vs. Current

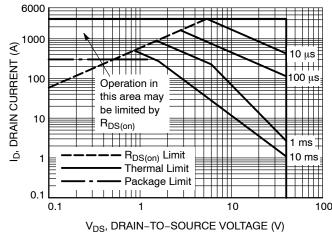


Figure 11. Maximum Rated Forward Biased Safe Operating Area

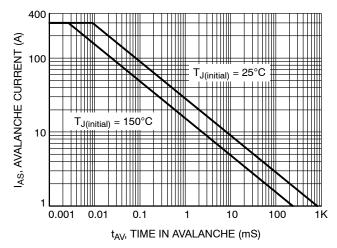


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

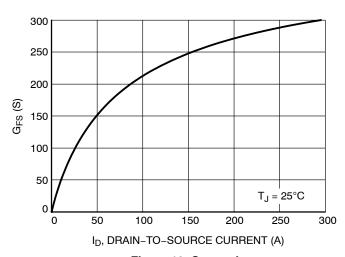


Figure 13. G_{FS} vs. I_D

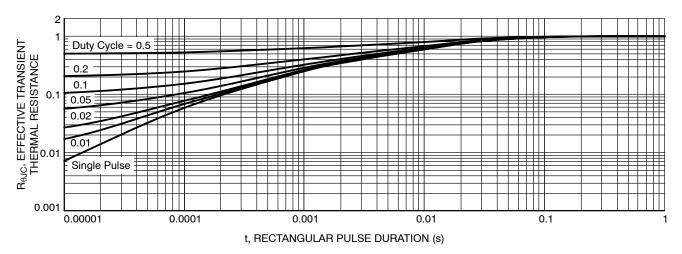


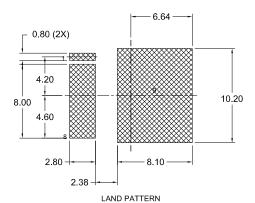
Figure 14. Transient Thermal Impedance



В (2x) a ccc D2 (2x) TERMINAL 1 CORNER Α INDEX AREA <u>5</u> (DATUM A) b (8x) bbbM C A B D4 (2x) E2 (2x) ddd(M) C L2 (8x) ·L1 🙆 SECTION "A-A" TOP VIEW DETAIL "B" η(4X) Θ // aaa C SIDE VIEW D1 DETAIL "B" SCALE: 2X D5 (2x) D6 D3 (2x) (2x)L3 (DATUM A) F6 (3x)E1 E3 E4 F5 √ b2 (8x)

H-PSOF8L 11.68x9.80x2.30, 1.20P CASE 100CU **ISSUE F**

DATE 30 JUL 2024



RECOMMENDATION *FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

HATCHED AREA

SCALE: 2X

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE B.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- 3. "e" REPRESENTS THE TERMINAL PITCH.
- 4. THIS DIMENSION INCLUDES ENCAPSULATION THICKNESS "A1", AND PACKAGE BODY THICKNESS, BUT DOES NOT INCLUDE ATTACHED FEATURES, e.g., EXTERNAL OR CHIP CAPACITORS. AN INTEGRAL HEATSLUG IS NOT CONSIDERED AS ATTACHED FEATURE. 5. A VISUAL INDEX FEATURE MUST BE LOCATED WITHIN THE
- 6. DIMENSIONS b1,L1,L2 APPLY TO PLATED TERMINALS.
- 7. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL.
 8. THE LOCATION AND NUMBER OF FUSED LEADS ARE OPTIONAL.

DIM	MILLIMETERS					
	MIN.	NOM.	MAX.			
Α	2.20	2.30	2.40			
A1	1.70	1.80	1.90			
b	0.70	0.80	0.90			
b1	9.70	9.80	9.90			
b2	0.35	0.45	0.55			
С	0.40	0.50	0.60			
D	10.28	10.38	10.48			
D/2	5.09	5.19	5.29			
D1	10.98	11.08	11.18			
D2	3.20	3.30	3.40			
D3	2.60	2.70	2.80			
D4	4.45	4.55	4.65			
D5	3.20	3.30	3.40			
D6	0.55	0.65	0.75			
E	9.80	9.90	10.00			
E1	7.30	7.40	7.50			
E2	0.30	0.40	0.50			
E3	7.40	7.50	7.60			
E4	8.20	8.30	8.40			

DIM	MILLIMETERS			
D _{II} VI	MIN.	NOM.	MAX.	
E5	9.36	9.46	9.56	
E6	1.10	1.20	1.30	
E7	0.15	0.18	0.21	
е		1.20 BSC	;	
e/2	(0.60 BSC	;	
Н	11.58	11.68	11.78	
H/2	5.74	5.84	5.94	
H1		7.15 BSC)	
L	1.90	2.00	2.10	
L1	0.60	0.70	0.80	
L2	0.50	0.60	0.70	
L3	0.70 0.80 0.90			
θ		10° REF		
θ1	10° REF			
aaa	0.20			
bbb	0.25			
ccc	0.20			
ddd	0.20			
eee	0.10			

GENERIC MARKING DIAGRAM*

HEAT SLUG TERMINAL

Α = Assembly Location

BOTTOM VIEW

D/2

= Year

<u>/8</u>\

L (8x)

(DATUM B)

WW = Work Week

= Assembly Lot Code XXXX = Specific Device Code

AYWWZZ XXXXXXX XXXXXXX

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	H-PSOF8L 11.68x9.80x2.30, 1.20P		PAGE 1 OF 1	

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